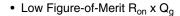


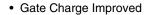
Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V) at T _J max.	560			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	1		
Q _g (Max.) (nC)	34			
Q _{gs} (nC)	7.8			
Q _{gd} (nC)	10.4			
Configuration	Single			

FEATURES







- T_{rr}/Q_{rr} Improved
- Compliant to RoHS Directive 2002/95/EC





TO-220 FULLPAK	D P
G D S	G
ű	N-Channel MOSFET

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	SiHF8N50L-E3

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	500	.,	
Gate-Source Voltage			V_{GS}	± 30	V	
Continuous Drain Currenta	V _{GS} at 10 V	T _C = 25 °C	I _D	8	Α	
Pulsed Drain Current ^b	ulsed Drain Current ^b			22	^	
Linear Derating Factor				0.32	W/°C	
Single Pulse Avalanche Energy ^c			E _{AS}	180	mJ	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	40	W	
Peak Diode Recovery dV/dt ^d			dV/dt	24	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)e	for 10 s			300	1	

- a. Drain current limited by maximum junction temperature.
- b. Repetitive rating; pulse width limited by maximum junction temperature. c. $V_{DD}=50~V$, starting $T_J=25~^{\circ}C$, L=10~mH, $R_g=25~\Omega$, $I_{AS}=6~A$.
- d. $I_{SD} \le 8$ A, $dI/dt \le 460$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- e. 1.6 mm from case.

SiHF8N50L

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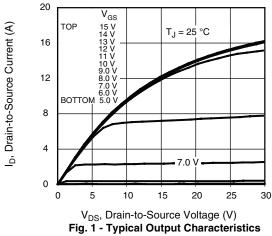


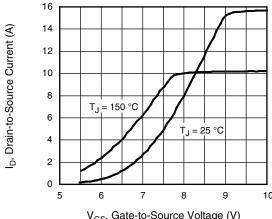
THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.1	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.5	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		-	5.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 30 V		-	± 100	nA
Zoro Coto Voltago Drain Current		V _{DS} =	= 500 V, V _{GS} = 0 V	-	-	50	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 V	/, V _{GS} = 0 V, T _J = 125 °C	-	-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 4.0 A	-	0.85	1	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 50 V, I _D = 3 A		-	2	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 V$,		-	873	-	pF
Output Capacitance	C _{oss}	1	$V_{DS} = 25 \text{ V},$		105	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz		-	11	-	
Total Gate Charge	Qg		= 0 V I _D = 6 A, V _{DS} = 400 V	-	22	34	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 0 V		-	7.8	-	
Gate-Drain Charge	Q_{gd}	1		-	10.4	-	
Turn-On Delay Time	t _{d(on)}			-	17.3	-	
Rise Time	t _r	$V_{DD} = 250 \text{ V}, I_{D} = 6 \text{ A}$ $R_{G} = 14 \Omega, V_{GS} = 10 \text{ V}$		-	35	-	ns
Turn-Off Delay Time	t _{d(off)}			-	23.6	-	
Fall Time	t _f			-	17	-	
Gate Input Resistance	R_{g}	f = 1 MHz, open drain		-	0.7	-	Ω
Drain-Source Body Diode Characteristic	s	-		"	•		
Continuous Source-Drain Diode Current	I _S	showing the	MOSFET symbol showing the		-	8	
Pulsed Diode Forward Current	I _{SM}	integral reverse p - n junction diode		-	-	22	A
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 8 A, V _{GS} = 0 V		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 ^{\circ}\text{C}, \ I_F = I_S, \ dI/dt = 100 \ A/\mu s, \ V_R = 15 \ V$		-	63	-	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	114	-	nC
Body Diode Reverse Recovery Current	I _{RRM}			-	3.3	-	Α



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





 $\mbox{V}_{\mbox{GS}},$ Gate-to-Source Voltage (V) Fig. 3 - Typical Transfer Characteristics

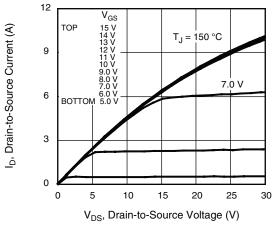


Fig. 2 - Typical Output Characteristics

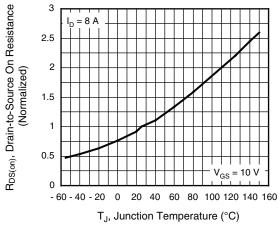


Fig. 4 - Normalized On-Resistance vs. Temperature

SiHF8N50L

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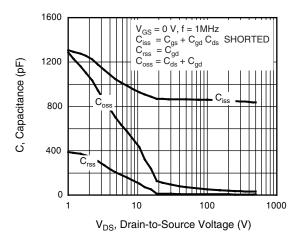


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

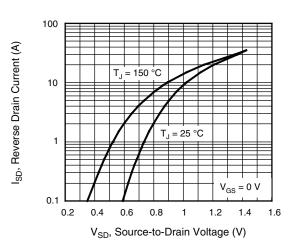


Fig. 7 - Typical Source-Drain Diode Forward Voltage

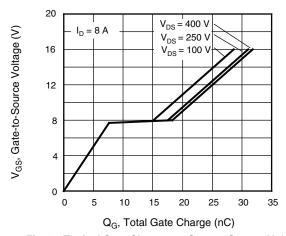


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

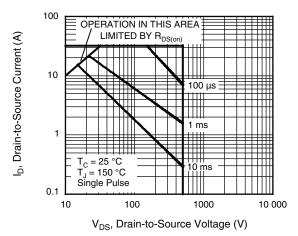


Fig. 8 - Maximum Safe Operating Area

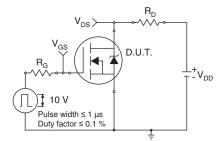


Fig. 9a - Switching Time Test Circuit

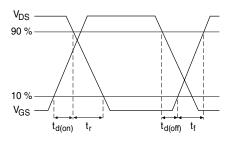


Fig. 9b - Switching Time Waveforms



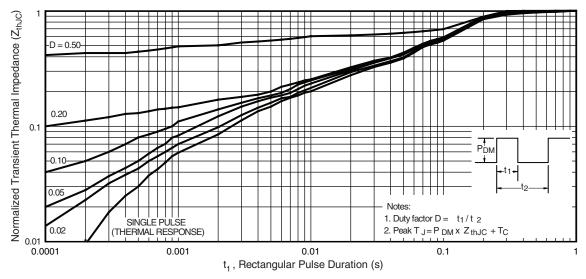


Fig. 10 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

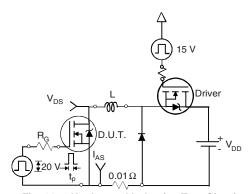


Fig. 11a - Unclamped Inductive Test Circuit

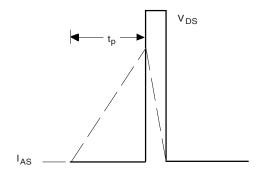


Fig. 11b - Unclamped Inductive Waveforms

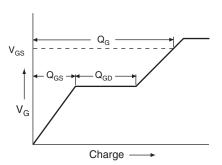


Fig. 12a - Basic Gate Charge Waveform

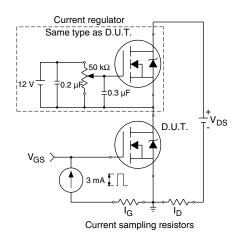
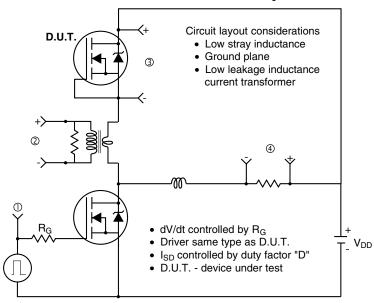
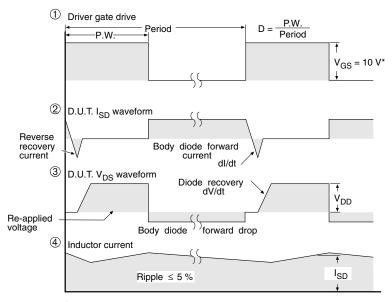


Fig. 12b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level devices

Fig. 13 - For N-Channel

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